

Notice of References Cited

Application/Control No.

10/033,525

Applicant(s)/Patent Under
Reexamination
PULLELA ET AL.

Examiner

DINH T. LE

Art Unit

2816

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-3,917,957 <i>DL</i>	11-1975	SWIATOWIEC et al	377/107
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